

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/767,230	OHNISHI ET AL.
	<b>Examiner</b> Andy Huynh	<b>Art Unit</b> 2818

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST 257/E21.277,758-760,762,763,751 (text search-see search history printout)	11/4/2005	AH
Intereference Search History Printout	11/4/2005	AH